3W Mono Class-D Audio Power Amplifier

## Features

- Operating Voltage: 2.4V-5.5V
- High efficiency up to $90 \%$
- Low Supply Current
$-I_{D D}=2 \mathrm{~mA}$ at $V_{D D}=5 \mathrm{~V}$
$-I_{D D}=1.6 \mathrm{~mA}$ at $V_{D D}=3.6 \mathrm{~V}$
- Low Shutdown Current
$-I_{D D}=1 \mu A$ at $V_{D D}=5 V$
- Output Power
at $1 \%$ THD $+N$ (TDFN3x3-8)
-1.3 W , at $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=8 \Omega$
-0.6 W , at $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=8 \Omega$
- 2.4W, at $V_{D D}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=4 \Omega$ (WLCSP-9)
-2.1 W , at $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=4 \Omega$
-1.2 W , at $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=4 \Omega$
at $10 \%$ THD $+N$ (TDFN3x3-8)
-1.6 W , at $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=8 \Omega$
-0.8 W , at $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=8 \Omega$
-3.1 W , at $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=4 \Omega$ (WLCSP-9)
-2.65 W , at $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=4 \Omega$
-1.3 W , at $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=4 \Omega$
- Less External Components Required
- Fast Startup Time (4 ms)
- High PSRR: 80 dB at 217 Hz
- Thermal and Over-Current Protections
- Space Saving Packages WLCSP-9 Bump, 3mmx3mm TDFN-8
- Lead Free Available (RoHS Compliant)


## General Description

The APA2010/2010A is a mono, filter-free Class-D audio amplifier available in a WLCSP-9 and TDFN3x3-8 packages. The gain can be set by an external input resistance. High PSRR and differential architecture provide increased immunity to noise and RF rectification. In addition to these features, a fast startup time and small package size make the APA2010/2010A an ideal choice for both cellular handsets and PDAs.
The APA2010/2010A is capable of driving 1.5 W at 5 V or 730 mW at 3.6 V into $8 \Omega$. It is also capable of driving $4 \Omega$. The APA2010/2010A is designed with a Class-D architecture and operating with highly efficiency compared with Class-AB amplifier. It's suitable for power sensitive application, such as battery powered devices. The filterfree architecture eliminates the output filter, reduces the external component count, board area, and system costs, and simplifies the design.
Moreover, the APA2010/2010A provides thermal and overcurrent protections.

## Applications

- Mobile Phones
- Handsets
- PDAs
- Portable multimedia devices


## Ordering and Marking I nformation



Note 1: ANPEC lead-free products contain molding compounds/die attach materials and 100\% matte tin plate termination finish; which are fully compliant with RoHS and compatible with both SnPb and lead-free soldering operations. ANPEC leadfree products meet or exceed the lead-free requirements of IPC/JEDEC J STD-020C for MSL classification at lead-free peak reflow temperature.

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Pin Configurations (Note 2)


WLCSP-9 Top View
Note 2: The marking for APA2010 is "A20" and "A21" is for APA2010A


Top View

## Absolute Maximum Ratings (Note 3)

(Over operating free-air temperature range unless otherwise noted.)

| Symbol | Parameter | Rating | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply Voltage (VDD, PVDD) | -0.3 to 6 | V |
| $\mathrm{~V}_{\mathrm{IN}}, \mathrm{V}_{\mathrm{SD}}$ | Input Voltage (SD, INP, INN) | -0.3 to 6 | V |
| $\mathrm{~T}_{\mathrm{A}}$ | Operating Ambient Temperature Range | -40 to 85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{J}}$ | Maximum Junction Temperature | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{STG}}$ | Storage Temperature Range | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {SDR }}$ | Maximum Lead Soldering Temperature, 10 Seconds | 260 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation | Internally Limited | W |

Notes 3: Absolute Maximum Ratings are those values beyond which the life of a device may be impaired. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Thermal Characteristics (Note 4)

| Symbol | Parameter |  | Value | Unit |
| :---: | :---: | :---: | :---: | :---: |
| $\theta_{\text {JA }}$ | Thermal Resistance -Junction to Ambient | $\begin{aligned} & \text { WLCSP-9 } \\ & \text { TDFN3×3-8 }{ }^{\text {(Note 2) }} \end{aligned}$ | $\begin{gathered} 165 \\ 50 \end{gathered}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

Note 4 : Please refer to "Layout Recommendation", the ThermalPad on the bottom of the IC should soldered directly to the PCB's ThermalPad area that with several thermal vias connect to the ground plan, and the PCB is a 2-layer, 5 -inch square area with 20 copper thickness.

## Recommended Operating Conditions

|  |  | Min. | Max. | Unit |
| :--- | :--- | :---: | :---: | :---: |
| Supply Voltage $\mathrm{V}_{\mathrm{DD}}$ | $\overline{\mathrm{SD}}$ | 2.4 | 5.5 | V |
| High level threshold voltage, $\mathrm{V}_{\mathrm{H}}$ | $\overline{\mathrm{SD}}$ | 1 |  | V |
| Low level threshold voltage, $\mathrm{V}_{\mathrm{IL}}$ |  | 0.35 | V |  |

## Electrical Characteristics

$\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ (unless otherwise noted)

| Symbol | Parameter | Test Condition |  | APA2010/2010A |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min. | Typ. | Max. |  |
| $I_{\text {D }}$ | Supply Current |  |  |  | 2 |  | mA |
| $1{ }_{\text {SD }}$ | Shutdown Current | $\overline{\mathrm{SD}}=0 \mathrm{~V}$ |  |  | 1 |  | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{i}}$ | Input current | $\overline{\text { SD }}$ |  |  | 0.1 |  | $\mu \mathrm{A}$ |
| $\mathrm{F}_{\text {osc }}$ | Oscillator Frequency |  |  | 200 | 250 | 300 | kHz |
| $\mathrm{R}_{\text {DScon }}$ | Static drain-source on-state resistance | $V_{D D}=5 \mathrm{~V}$ | P-Channel MOSFET (WLCSP-9) |  | 340 |  | $\mathrm{m} \Omega$ |
|  |  |  | N-Channel MOSFET (WLCSP-9) |  | 195 |  |  |
|  |  | $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V}$ | P-Channel MOSFET (WLCSP-9) |  | 400 |  |  |
|  |  |  | N-Channel MOSFET (WLCSP-9) |  | 215 |  |  |
|  |  | $\mathrm{V}_{\mathrm{DD}}=2.4 \mathrm{~V}$ | P-Channel MOSFET (WLCSP-9) |  | 550 |  |  |
|  |  |  | N-Channel MOSFET (WLCSP-9) |  | 260 |  |  |
| $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  |  |  |  |  |  |
| Po | Output Power | $\begin{aligned} & \mathrm{THD}+\mathrm{N}=1 \%, \\ & \mathrm{f}_{\text {in }}=1 \mathrm{kHz} \end{aligned}$ | $\mathrm{R}_{\mathrm{L}}=4 \Omega$ <br> (WLCSP-9) |  | 2.45 |  | W |
|  |  |  | $\mathrm{R}_{\mathrm{L}}=4 \Omega$ |  | 2.1 |  |  |
|  |  |  | $\mathrm{R}_{\mathrm{L}}=8 \Omega$ | 1 | 1.3 |  |  |
|  |  | $\begin{aligned} & \mathrm{THD}+\mathrm{N}=10 \%, \\ & \mathrm{f}_{\mathrm{in}}=1 \mathrm{kHz} \end{aligned}$ | $\mathrm{R}_{\mathrm{L}}=4 \Omega$ <br> (WLCSP-9) |  | 3.1 |  |  |
|  |  |  | $\mathrm{R}_{\mathrm{L}}=4 \Omega$ |  | 2.65 |  |  |
|  |  |  | $\mathrm{R}_{\mathrm{L}}=8 \Omega$ |  | 1.6 |  |  |
| THD+N | Total Harmonic Distortion Pulse Noise | $\mathrm{f}_{\text {in }}=1 \mathrm{kHz}$ | $\begin{aligned} & \hline \mathrm{R}_{\mathrm{L}}=4 \Omega \\ & \mathrm{P}_{\mathrm{O}}=1.6 \mathrm{~W} \\ & \hline \end{aligned}$ |  | 0.3 |  | \% |
|  |  |  | $\begin{aligned} & \hline \mathrm{R}_{\mathrm{L}}=8 \Omega \\ & \mathrm{P}_{\mathrm{O}}=0.96 \mathrm{~W} \\ & \hline \end{aligned}$ |  | 0.1 |  |  |
| PSRR | Power Supply Rejection Ratio | $\mathrm{R}_{\mathrm{L}}=8 \Omega, \mathrm{f}_{\text {in }}=217 \mathrm{~Hz}$ |  |  | 80 |  | dB |
| $V_{\text {os }}$ | Output Offset Voltage | $\mathrm{R}_{\mathrm{L}}=8 \Omega$ |  |  |  | 25 | mV |
| S/N |  | With A-weighting Filter$\mathrm{P}_{\mathrm{O}}=0.96 \mathrm{~W}, \mathrm{R}_{\mathrm{L}}=8 \Omega$ |  |  | 90 |  | dB |
| Vn | Noise Output Voltage | With A-weighting Filter |  |  | 100 |  | $\mu \mathrm{V}$ <br> (rms) |

## Electrical Characteristics (Cont.)

$\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ (unless otherwise noted)


## Typical Operating Characteristics



Output Power vs. Load Resistance


Output Power vs. Supply Voltage


Efficiency vs. Output Power ( $4 \Omega$ )


Output Power vs. Load Resistance


THD+N vs. Output Power


## Typical Operating Characteristics (Cont.)



THD+N vs. Frequency


THD+N vs. Output Power


THD+N vs. Frequency


THD+N vs. Frequency


THD+N vs. Frequency


## Typical Operating Characteristics (Cont.)

THD+N vs. Frequency


Frequency Response


CMRR vs. Frequency


THD+N vs. Frequency


CMRR vs. Frequency


PSRR vs. Frequency


## Typical Operating Characteristics (Cont.)



Output Noise Voltage vs. Frequency


Supply Current vs. Output Power


Output Noise Voltage vs. Frequency


Supply Current vs. Output Power


Supply Current vs. Supply Voltage


## Typical Operating Characteristics (Cont.)



GSM Power Supply Rejection vs. Time


Common Mode Rejection ratio vs. Common


## Pin Description

| Pin (WLCSP-9) |  | I/O |  |
| :---: | :---: | :---: | :--- |
| NO. | Name |  | Function Description |
| A1 | INP | I | The non-inverting input of amplifier. INP is connected to Gnd via a capacitor for <br> single-end (SE) input signal. |
| A2 | GND | - | Ground connection for circuitry. |
| A3 | VON | O | The negative output terminal of Class-D amplifier. |
| B1 | VDD | - | Supply voltage input pin. |
| B2 | PVDD | - | Supply voltage only for power stage. |
| B3 | PGND | - | Ground connection for power stage |
| C1 | INN | I | The inverting input of amplifier. INN is used as audio input terminal, typically. |
| C2 | $\overline{S D}$ | I | Shutdown mode control signal input, place entire IC in shutdown mode when held low. |
| C3 | VOP | O | The positive output terminal of Class-D amplifier. |


| Pin (TDFN3x3-8) |  | I/O |  |
| :---: | :---: | :---: | :--- |
| NO. | Name |  | Function Description |
| 1 | $\overline{S D}$ | I | Shutdown mode control signal input, place entire IC in shutdown mode when held low. |
| 2 | NC | - | No connection. |
| 3 | INP | I | The non-inverting input of amplifier. INP is connected to Gnd via a capacitor for <br> single-end (SE) input signal. |
| 4 | INN | I | The inverting input of amplifier. INN is used as audio input terminal, typically. |
| 5 | VOP | O | The positive output terminal of Class-D amplifier. |
| 6 | VDD | - | Supply voltage input pin |
| 7 | GND | - | Ground connection. |
| 8 | VON | O | The negative output terminal of Class-D amplifier. |

## Block Diagram



* APA2010 : 150k $\Omega$, APA2010A : 125k $\Omega$


## Typical Application Circuits



Single-ended input mode (WLCSP-9)


## Application I nformation

## Fully Differential Amplifier

The APA2010/2010A is a fully distinctive amplifier with differential inputs and outputs. Compare with the tranditional amplifiers, the fully differential amplifier has some advantages. Firstly, there is no need for the input coupling capacitors because the common-mode feedback will compensate the input bias. The inputs can be biased from 0.5 V to $\mathrm{V}_{D D}-0.5 \mathrm{~V}$, and the outputs still be biased at mid-supply of APA2010/2010A. If the inputs are biased out of the input range, the coupling capacitors are required. Secondly, there is no need for the mid-supply capacitor ( $C_{8}$ ) either because any shift of the mid-supply of APA2 ${ }^{B} 10 / 2010$ A will have the same affection on both positive \& negative channel, and will cancel at the differential outputs. Thirdly, the fully differential amplifier will cancel the GSM RF transmitter's signal $(217 \mathrm{~Hz})$.

Class-D Operation


Figure 1. The Class-D Power Amplifier Output Waveform (Voltage \& Current)

The APA2010/2010A modulation scheme is shown in figure 1. The ouputs VOP and VON are in phase with each other when no input signals. When output $>0 \mathrm{~V}$, the duty cycle of VOP is greater than $50 \%$ and $\mathrm{V}_{\text {oN }}$ is less than $50 \%$; on the contrary, when output $<0 \mathrm{~V}$, the duty cycle of VOP is less than $50 \%$ and VON is greater than $50 \%$. This method reduces the switching current across the load and the $I^{2} R$ losses in the load which can improve the amplifier's efficiency.
This modulation scheme has very short pulses across the load which results in the small ripple current and very little loss on the load. Meanwhile, the LC filter can be eliminated in most applications. Adding the LC filter can increase the efficiency by filtering the ripple current.

## Square Wave Into the Speaker

Applying the square wave into the speaker may cause the voice coil of speaker jumping out the air gap and defacing the voice coil. However, this depends on if the amplitude of square wave is high enough and the bandwidth of speaker is higher than the square wave's frequency. For 250 kHz switching frequency, this is not an issue for the speaker because the frequency is beyond the audio band and can't significantly move the voice coil, as cone movement is proportional to $1 / f^{2}$ for frequency out of audio band.

Input Resistance, $\mathbf{R}_{\text {in }}$
The gain of the APA2010/2010A has been set by the external resistors $\left(\mathrm{R}_{\mathrm{in}}\right)$.

$$
\begin{equation*}
\operatorname{Gain}(\mathrm{Av})=\frac{2 \mathrm{X} 150 \mathrm{k} \Omega(\text { or } 125 \mathrm{k} \Omega)}{\mathrm{R}_{\mathrm{in}}} \tag{1}
\end{equation*}
$$

For fully differential operanting, the $\mathrm{R}_{\text {in }}$ match is very important for CMRR, PSRR and harmonic distortion performance. It's recommended to use $1 \%$ tolerance resistor or better. Keeping the input trace as short as possible to limit the noise injection.
The gain is recommended to set as $2 \mathrm{~V} / \mathrm{V}$ or lower for APA2010/2010A's optimal performance.

## Input Capacitor, $\mathrm{C}_{\text {in }}$

In the typical application, an input capacitor, $\mathrm{C}_{\text {in }}$, is required to allow the amplifier to bias the input signal to the proper DC level for optimum operation. In this case, $\mathrm{C}_{\text {in }}$ and the minimum input impedance $\mathrm{R}_{\text {in }}$ from a high-pass filter with the corner frequency are determined in the following equation:

## Application Information (Cont.)

Input Capacitor, $\mathrm{C}_{\mathrm{i}}$ (Cont.)

$$
\begin{equation*}
\mathrm{F}_{\mathrm{C} \text { (highpass) }}=\frac{1}{2 \pi \mathrm{R}_{\mathrm{in}} \mathrm{C}_{\mathrm{in}}} \tag{2}
\end{equation*}
$$

It is important to consider the value of $\mathrm{C}_{\text {in }}$ as it directly affects the low frequency performance of the circuit. For example, when $R_{\text {in }}$ is $150 \mathrm{k} \Omega$ and the specification calls for a flat bass response are down to 20 Hz . Equation is reconfigured as followed:

$$
\begin{equation*}
\mathrm{C}_{\mathrm{in}}=\frac{1}{2 \pi \mathrm{R}_{\mathrm{in}} \mathrm{~F}_{\mathrm{c}}} \tag{3}
\end{equation*}
$$

When input resistance is considered, the $\mathrm{C}_{\text {in }}$ is $0.05 \mu \mathrm{~F}$ so one would likely choose a value in the range of $0.068 \mu \mathrm{~F}$ to $0.1 \mu \mathrm{~F}$. A further consideration for this capacitor is the leakage path from the input source through the input network ( $R_{\text {in }}+R_{f}, C_{i n}$ ) to the load.
This leakage current creates a DC offset voltage at the input to the amplifier that reduces useful headroom, especially in high gain applications. For this reason, a low-leakage tantalum or ceramic capacitor is the best choice. When polarized capacitors are used, the positive side of the capacitor should face the amplifier input in most applications as the $D C$ level is held at $V_{D D} / 2$, which is likely higher than the source DC level. Please note that it is important to confirm the capacitor polarity in the application.

## Output Capacitor, $\mathrm{C}_{\text {。 }}$

If the user wants to add capacitor at output without ferrite bead and inductor, please note the output capacitor should not be greater than $1 \mathrm{nf}\left(\mathrm{V}_{\mathrm{DD}}=4.2 \mathrm{~V}\right)$. The high value of output capacitor maybe trigger the OCP (Over-Current Protection) of APA2010/2010A.

## Power Supply Decoupling, $\mathrm{C}_{\mathrm{s}}$

The APA2010/2010A is a high-performance CMOS audio amplifier that requires adequate power supply decoupling to ensure the output total harmonic distortion (THD +N ) is as low as possible. Power supply decoupling also prevents the oscillations causing by long lead length between the amplifier and the speaker.

The optimum decoupling is achieved by using two different types of capacitors that target on different types of noise on the power supply leads. For higher frequency transients,
spikes, or digital hash on the line, a good low equivalent-series-resistance (ESR) ceramic capacitor, typically $0.1 \mu \mathrm{~F}$, is placed as close as possible to the device VDD pin for the best operation. For filtering lower frequency noise signals, a large aluminum electrolytic capacitor of $10 \mu \mathrm{~F}$ or greater is placed near the audio power amplifier is recommended.

## Shutdown Function

In order to reduce power consumption while not in use, the APA2010/2010A contains a shutdown function to externally turn off the amplifier bias circuitry. This shutdown feature turns the amplifier off when logic low is placed on the $\overline{\mathrm{SD}}$ pin for APA2010/2010A. The trigger point between a logic high and logic low level is typically 0.4VDD. It's suggestion to switch to either ground or the supply voltage VDD to provide maximum device performance. By switching the $\overline{\mathrm{SD}}$ pin to low level, the amplifier enters a low-consumption-current state, and then the APA2010/ 2010A is in shutdown mode. In normal operating, APA2010/2010A's $\overline{S D}$ pin should be pulled to high level to keep the IC out of the shutdown mode. The $\overline{\mathrm{SD}}$ pin should be tied to a definite voltage to avoid unwanted state changes.

## Output LC Filter

If the traces from the APA2010/2010A to speaker are short, the APA2010/2010A doesn't require output filter for FCC \& CE standard.

A ferrite bead may be need if it's failing the test for FCC or CE is tested without the LC filter. The Figure 2 is the sample for adding ferrite bead; the ferrite shows when choosing high impedance in high frequency.


Figure 2. Ferrite bead output filter
Figure 3 is an example for adding the LC filter. It's recommended to eliminate the radiated emission or EMI when the trace from amplifier to speaker is too long.

## Application I nformation (Cont.)

Output LC Filter (Cont.)


Figure 3. LC output filter
Figure 3's low pass filter cut-off frequency is $F_{c}$

$$
\begin{equation*}
\mathrm{F}_{\mathrm{C}(\text { lowpass })}=\frac{1}{2 \pi \sqrt{\mathrm{LC}}} \tag{4}
\end{equation*}
$$

## Mixing Two Single-Ended Input Signals



Figure 4. Mixing Two Single-Ended Input Signals
For mixing two Single-Ended (SE) input signals, please refer to Figure 4. The gains of each input can be set difference:

$$
\begin{align*}
& \mathrm{A}_{\mathrm{V}}(1)=\frac{2 \times 150 \mathrm{k} \Omega(\text { or } 125 \mathrm{k} \Omega)}{\mathrm{R}_{1}}  \tag{5}\\
& \mathrm{~A}_{\mathrm{V}}(2)=\frac{2 \times 150 \mathrm{k} \Omega(\text { or } 125 \mathrm{k} \Omega)}{\mathrm{R}_{2}} \tag{6}
\end{align*}
$$

The corner frequency of each input high- pass-filter also can be set by $R_{1} \& C_{1}$, and $R_{2} \& C_{2}$.
The non-inverting input's resistor $\left(\mathrm{R}_{\mathrm{p}}\right)$ and capacitor $\left(\mathrm{C}_{\mathrm{p}}\right)$ need to match the impedances of invert inputs.

$$
\begin{align*}
& \mathrm{C}_{\mathrm{P}}=\mathrm{C}_{1} / / \mathrm{C}_{2}=\mathrm{C}_{1}+\mathrm{C}_{2}  \tag{7}\\
& \mathrm{R}_{\mathrm{P}}=\mathrm{R}_{1} / / \mathrm{R}_{2}=\frac{\mathrm{R}_{1} \times \mathrm{R}_{2}}{\mathrm{R}_{1}+\mathrm{R}_{2}} \tag{8}
\end{align*}
$$

## Layout Recommendation



Figure 5. WLCSP-9 land pattern recommendation


Figure 6. TDFN3x3-8 Layout Recommendation

## Application Information ( Cont.)

## Layout Recommendation (cont.)

1. All components should be placed close to the APA2010/2010A. For example, the input resistor ( $\mathrm{R}_{\text {in }}$ ) should be close to APA2010/2010A's input pins to avoid causing noise coupling to APA2010/2010A's high impedance inputs; the decoupling capacitor $\left(\mathrm{C}_{\mathrm{s}}\right)$ should be placed by the APA2010/2010A's power pin to decouple the power rail noise.
2. The output traces should be short, wide ( $>50 \mathrm{mil}$ ), and symmetric.
3. The input trace should be short and symmetric.
4. The power trace width should greater than 50 mil .
5. The TDFN3X3-8 Thermal PAD should be soldered on PCB, and the ground plane needs soldered mask (to avoid short circuit) except the Thermal PAD area.

## Package Information

## WLCSP1.5x1.5-9



| $\begin{aligned} & \text { S } \\ & \text { M } \\ & \text { B } \end{aligned}$ | WLCSP1.5x1.5-9 |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MILLIMETERS |  | INCHES |  |
|  | MIN. | MAX. | MIN. | MAX. |
| A | 0.53 | 0.67 | 0.021 | 0.026 |
| A1 | 0.20 | 0.24 | 0.008 | 0.009 |
| A2 | 0.33 | 0.43 | 0.013 | 0.017 |
| b | 0.29 | 0.31 | 0.011 | 0.012 |
| D | 1.47 | 1.53 | 0.058 | 0.060 |
| E | 1.47 | 1.53 | 0.058 | 0.060 |
| e | 0.50 BSC |  | 0.020 BSC |  |

## Package Information

TDFN3x3-8


| $\begin{aligned} & \mathrm{S} \\ & \mathrm{Y} \\ & \mathrm{M} \\ & \mathrm{~B} \\ & \mathrm{~L} \end{aligned}$ | TDFN3x3-8 |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MILLIMETERS |  | INCHES |  |
|  | MIN. | MAX. | MIN. | MAX. |
| A | 0.70 | 0.80 | 0.028 | 0.031 |
| A1 | 0.00 | 0.05 | 0.000 | 0.002 |
| A3 | 0.20 REF |  | 0.008 REF |  |
| b | 0.25 | 0.35 | 0.010 | 0.014 |
| D | 3.00 BSC |  | 0.118 BSC |  |
| D2 | 1.60 | 2.50 | 0.063 | 0.098 |
| E | 3.00 BSC |  | 0.118 BSC |  |
| E2 | 1.35 | 1.75 | 0.053 | 0.069 |
| e | 0.65 BSC |  | 0.026 BSC |  |
| L | 0.30 | 0.50 | 0.012 | 0.020 |

## Carrier Tape \& Reel Dimensions



| Application | A | H | T1 | C | d | D | W | E1 | F |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| WLCSP-9 | 178.0 $\pm 2.00$ | 50 MIN . | $\begin{array}{r} \hline 8.4+2.00 \\ -0.00 \\ \hline \end{array}$ | $\begin{array}{r} 13.0+0.50 \\ -0.20 \\ \hline \end{array}$ | 1.5 MIN. | 20.2 MIN. | $8.0 \pm 0.30$ | $1.75 \pm 0.10$ | $7.5 \pm 0.05$ |
|  | P0 | P1 | P2 | D0 | D1 | T | A0 | B0 | K0 |
|  | $4.0 \pm 0.10$ | $12.0 \pm 0.10$ | $2.0 \pm 0.10$ | $\begin{array}{r} 1.5+0.10 \\ -0.00 \\ \hline \end{array}$ | 1.5 MIN. | $0.6+0.00$ -0.40 | $1.70 \pm 0.10$ | $1.70 \pm 0.10$ | $0.90 \pm 0.10$ |
| Application | A | H | T1 | C | d | D | W | E1 | F |
| TDFN3x3-8 | 178.0 $\pm 2.00$ | 50 MIN . | $\begin{array}{r} 12.4+2.00 \\ -0.00 \\ \hline \end{array}$ | $\begin{array}{r} 13.0+0.50 \\ -0.20 \\ \hline \end{array}$ | 1.5 MIN. | 20.2 MIN. | $12.0 \pm 0.30$ | $1.75 \pm 0.10$ | $5.5 \pm 0.05$ |
|  | P0 | P1 | P2 | D0 | D1 | T | AO | B0 | K0 |
|  | $4.0 \pm 0.10$ | $12.0 \pm 0.10$ | $2.0 \pm 0.10$ | $\begin{array}{r} 1.5+0.10 \\ -0.00 \end{array}$ | 1.5 MIN. | $\begin{array}{r} \hline 0.6+0.00 \\ -0.40 \end{array}$ | $3.35 \pm 0.20$ | $3.35 \pm 0.20$ | $1.30 \pm 0.20$ |

## Devices Per Unit

| Package Type | Unit | Quantity |
| :---: | :---: | :---: |
| WLCSP-9 | Tape \& Reel | 3000 |
| TDFN3x3-8 | Tape \& Reel | 3000 |

## Reflow Condition (IR/Convection or VPR Reflow)



## Reliability Test Program

| Test item | Method | Description |
| :--- | :--- | :--- |
| SOLDERABILITY* | MIL-STD-883D-2003 | $245^{\circ} \mathrm{C}, 5 \mathrm{sec}$ |
| HOLT | MIL-STD-883D-1005.7 | $1000 \mathrm{Hrs} \mathrm{Bias} \mathrm{@125}^{\circ} \mathrm{C}$ |
| PCT | JESD-22-B, A102 | $168 \mathrm{Hrs}, 100 \% \mathrm{RH}, 121^{\circ} \mathrm{C}$ |
| TST | MIL-STD-883D-1011.9 | $-65^{\circ} \mathrm{C} \sim 150^{\circ} \mathrm{C}, 200 \mathrm{Cycles}$ |
| ESD | MIL-STD-883D-3015.7 | $\mathrm{VHBM}>2 \mathrm{KV}, \mathrm{VMM}>200 \mathrm{~V}$ |
| Latch-Up | JESD 78 | $10 \mathrm{~ms}, 1_{\mathrm{tr}}>100 \mathrm{~mA}$ |

* Solderability test doesn't apply to "WLCSP-9".


## Classification Reflow Profiles

| Profile Feature | Sn-Pb Eutectic Assembly | Pb-Free Assembly |
| :---: | :---: | :---: |
| Average ramp-up rate ( $\mathrm{T}_{\mathrm{L}}$ to $\mathrm{T}_{\mathrm{P}}$ ) | $3^{\circ} \mathrm{C} /$ second max. | $3^{\circ} \mathrm{C} /$ second max. |
| Preheat <br> - Temperature Min (Tsmin) <br> - Temperature Max (Tsmax) <br> - Time (min to max) (ts) | $\begin{gathered} 100^{\circ} \mathrm{C} \\ 150^{\circ} \mathrm{C} \\ 60-120 \text { seconds } \end{gathered}$ | $\begin{gathered} 150^{\circ} \mathrm{C} \\ 200^{\circ} \mathrm{C} \\ 60-180 \text { seconds } \end{gathered}$ |
| Time maintained above: <br> - Temperature ( $\mathrm{T}_{\mathrm{L}}$ ) <br> - Time ( $\mathrm{t}_{\mathrm{L}}$ ) | $\begin{gathered} 183^{\circ} \mathrm{C} \\ 60-150 \text { seconds } \end{gathered}$ | $\begin{gathered} 217^{\circ} \mathrm{C} \\ 60-150 \text { seconds } \end{gathered}$ |
| Peak/Classification Temperature (Tp) | See table 1 | See table 2 |
| Time within $5^{\circ} \mathrm{C}$ of actual Peak Temperature (tp) | 10-30 seconds | 20-40 seconds |
| Ramp-down Rate | $6^{\circ} \mathrm{C} /$ second max. | $6^{\circ} \mathrm{C} /$ second max. |
| Time $25^{\circ} \mathrm{C}$ to Peak Temperature | 6 minutes max. | 8 minutes max. |

Note: All temperatures refer to topside of the package. Measured on the body surface.

## Classification Reflow Profiles (Cont.)

Table 1. SnPb Eutectic Process - Package Peak Reflow Temperatures

| Package Thickness | Volume $\mathbf{m m}^{\mathbf{3}}$ <br> $<\mathbf{3 5 0}$ | Volume $\mathbf{~ m m}^{\mathbf{3}}$ <br> $\geq \mathbf{3 5 0}$ |
| :---: | :---: | :---: |
| $<2.5 \mathrm{~mm}$ | $240+0 /-5^{\circ} \mathrm{C}$ | $225+0 /-5^{\circ} \mathrm{C}$ |
| $\geq 2.5 \mathrm{~mm}$ | $225+0 /-5^{\circ} \mathrm{C}$ | $225+0 /-5^{\circ} \mathrm{C}$ |

Table 2. Pb-free Process - Package Classification Reflow Temperatures

| Package Thickness | Volume $\mathbf{~ m m}^{\mathbf{3}}$ <br> $<\mathbf{3 5 0}$ | ${\text { Volume } \mathbf{m m}^{\mathbf{3}}}^{\mathbf{3 5 0 - 2 0 0 0}}$ | Volume $\mathbf{~ m m}^{\mathbf{3}}$ <br> $\boldsymbol{> 2 0 0 0}$ |
| :---: | :---: | :---: | :---: |
| $<1.6 \mathrm{~mm}$ | $260+0^{\circ} \mathrm{C}^{*}$ | $260+0^{\circ} \mathrm{C}^{*}$ | $260+0^{\circ} \mathrm{C}^{*}$ |
| $1.6 \mathrm{~mm}-2.5 \mathrm{~mm}$ | $260+0^{\circ}{ }^{\circ}$ | $250+0^{\circ} \mathrm{C}^{*}$ | $245+0^{\circ} \mathrm{C}^{*}$ |
| $\geq 2.5 \mathrm{~mm}$ | $250+0^{\circ} \mathrm{C}^{*}$ | $245+0^{\circ} \mathrm{C}^{*}$ | $245+0^{\circ} \mathrm{C}^{*}$ |

* Tolerance: The device manufacturer/supplier shall assure process compatibility up to and including the stated classification temperature (this means Peak reflow temperature $+0^{\circ} \mathrm{C}$. For example $260^{\circ} \mathrm{C}+0^{\circ} \mathrm{C}$ ) at the rated MSL level.


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